

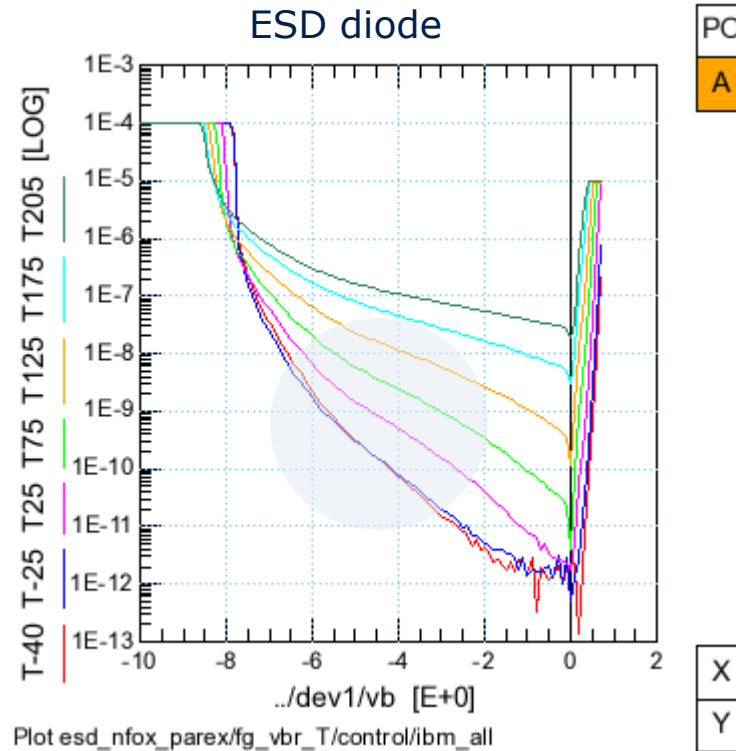
How to model the temperature dependence of a diode tunnel current

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ATV PTP TD EDA DCM



Tunnel current for a reverse biased ESD diode



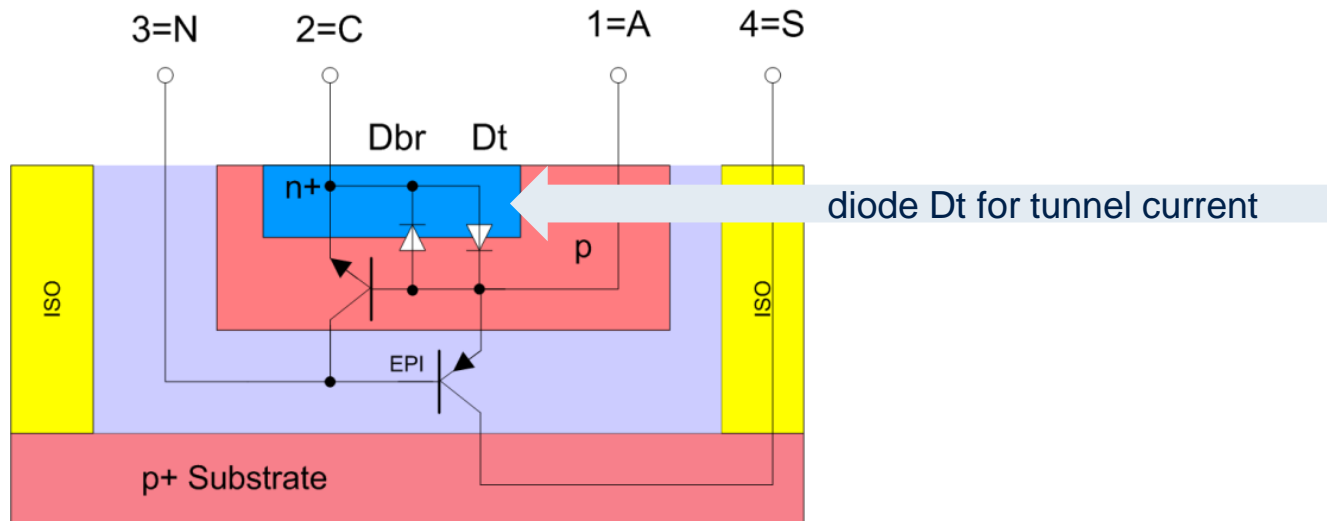
A typical curve for a ESD diode

The increasing current up to $V_{be} = -6V$ is called “tunnel current” here*, whereas at $-8V$ the avalanche effect takes place

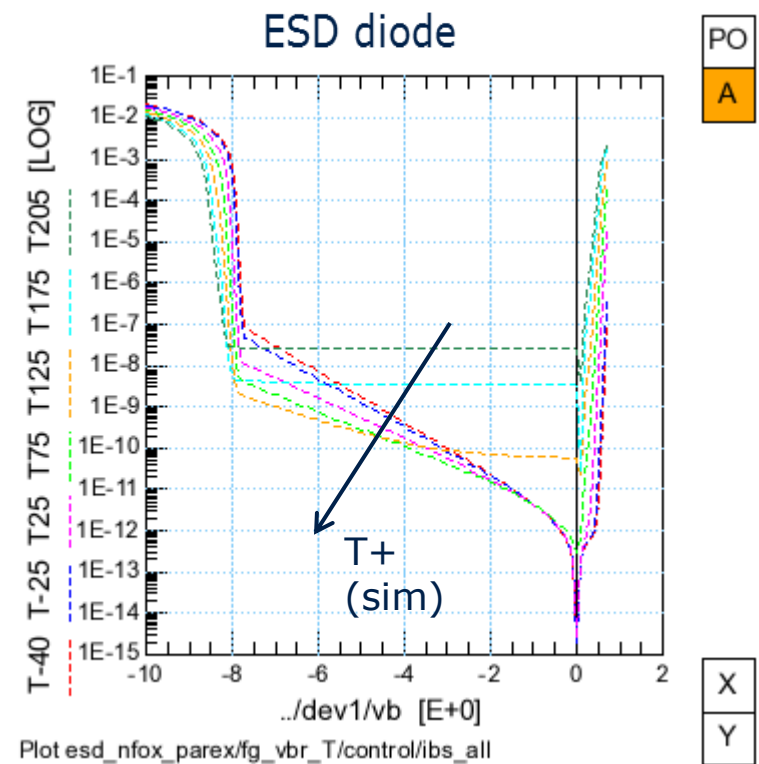
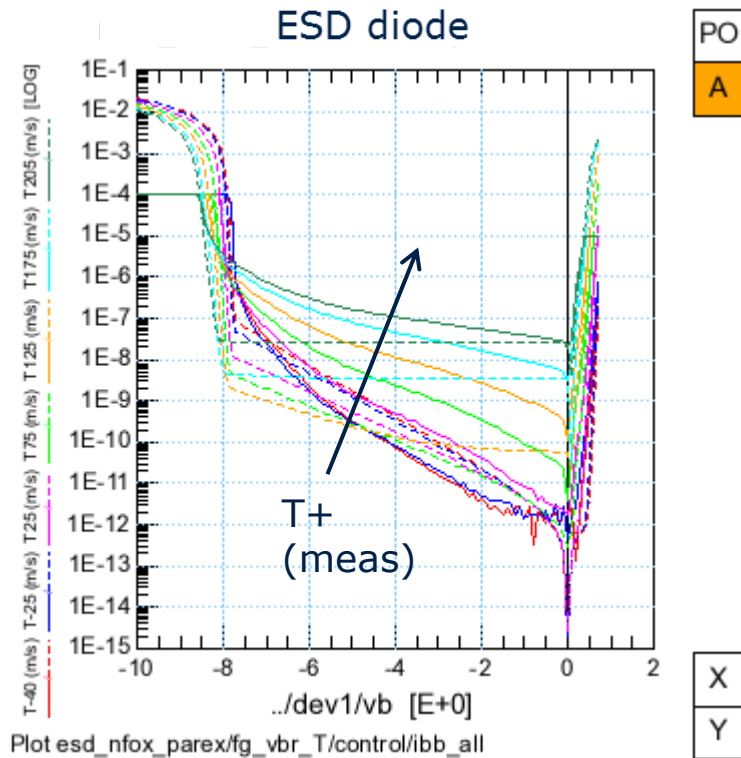
*according to Ashburn: SiGe HBTs, p.65

Tunnel current modeling using antiparallel diode Dt1

- Diode tunnel current may be simulated at room temperature using an antiparallel diode Dt1
- A very large emission coefficient value is necessary, e.g. $N=40$
- However, for such high N -values the temperature dependence of the current inverts!



Tunnel current modeling using antiparallel diode Dt

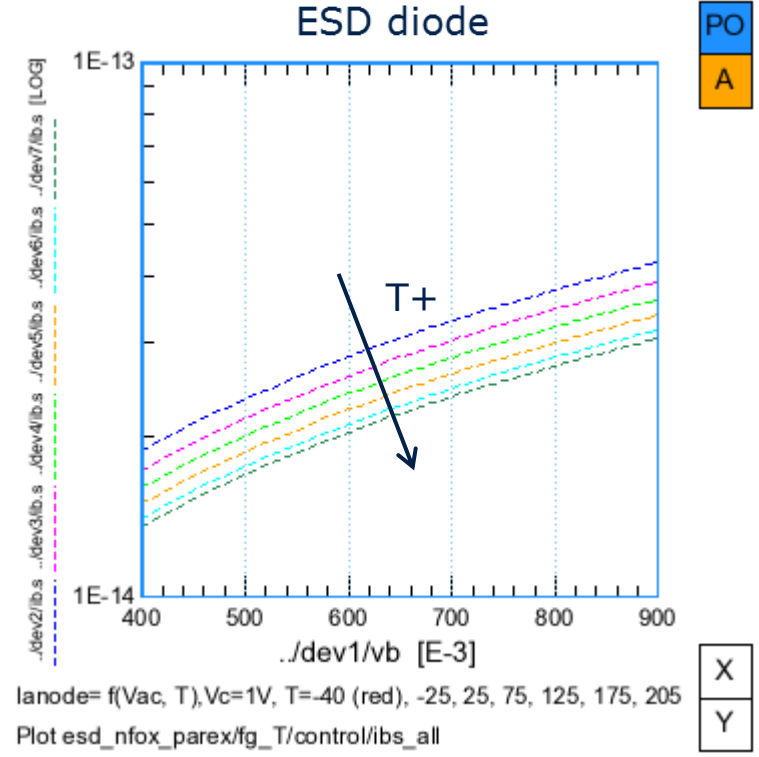
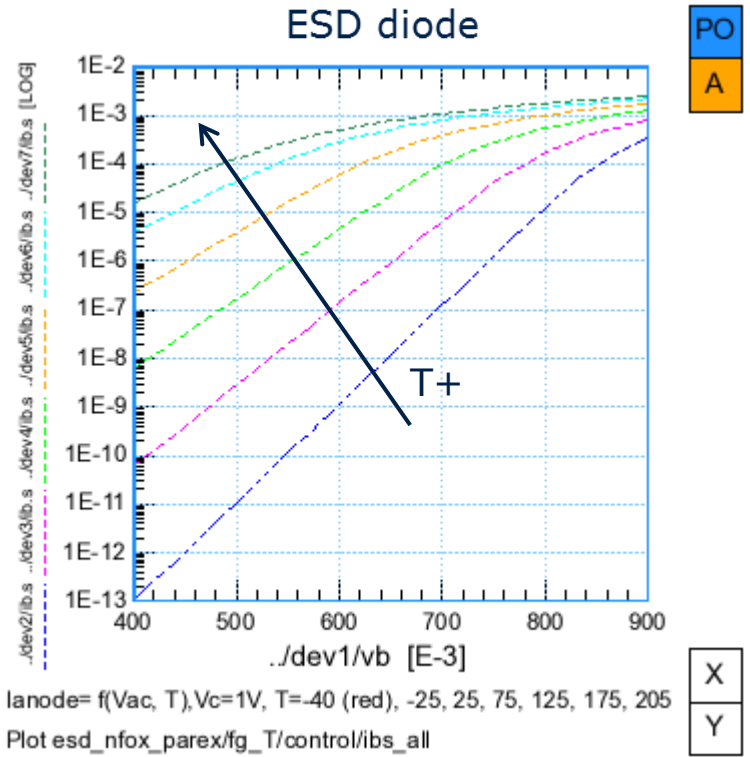


- Problem: antiparallel diode creates wrong temperature dependence in the tunnel current range
- Why?

Reason(1) Simulation Id(T) forward



■ Comparison: Id(T) @ N=1 and Id(T) @ N=10



■ Model parameters for simulation:
IS=10a, N=1, EG=1.11, XTI=3

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IS=10a, N=10, EG=1.11, XTI=3

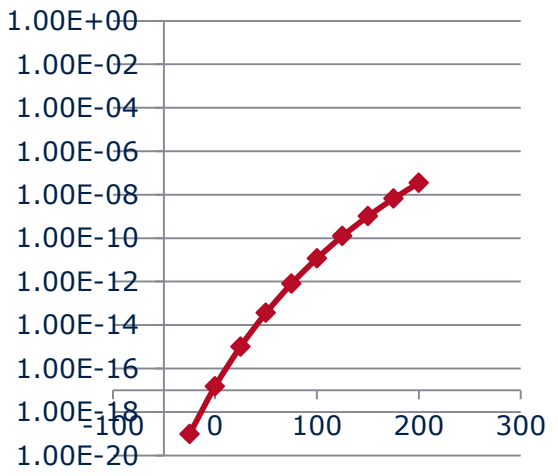
Reason(2) Id(T) for N=1



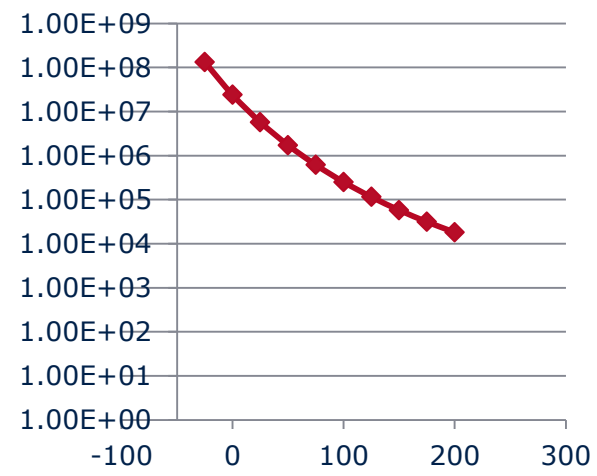
$$IS(T) = \underbrace{IS(T_0) \left[\frac{T}{T_0} \right]^{XTI/N}}_{IS(T)} \cdot \underbrace{\exp \left[\frac{EG}{N \cdot V_T(T_0)} \left(1 - \frac{T_0}{T} \right) \right]}_{IS-Multiplier}$$

$$I_D(T) = IS(T) \cdot \left[\exp \left(\frac{EG}{N \cdot V_T(T_0)} \right) - 1 \right]$$

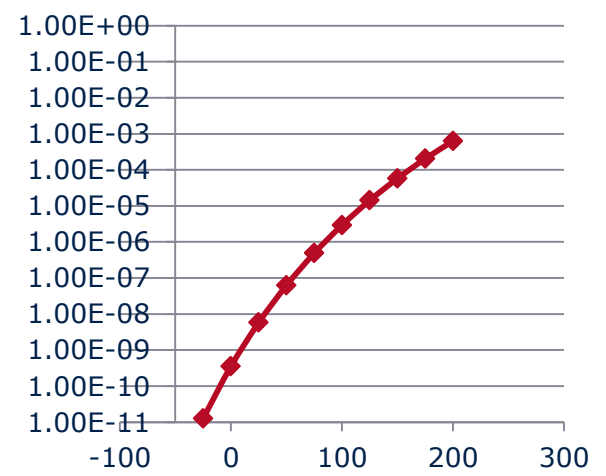
IS(T)



IS-Multiplier



Id(T)



Simulation using IS=1a, EG=1.11, XTI=3, N=1

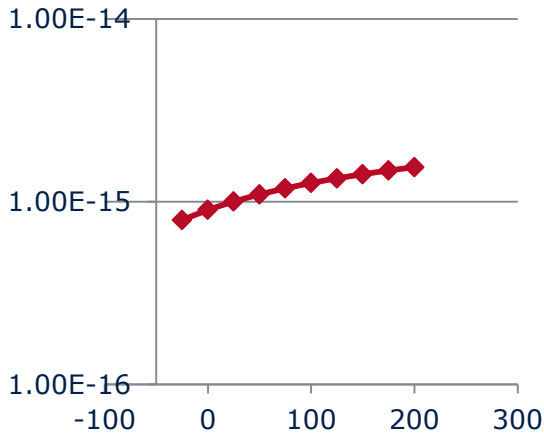
■ Result: positive TC of Id for N=1

Reason(3) Id(T) for N=40

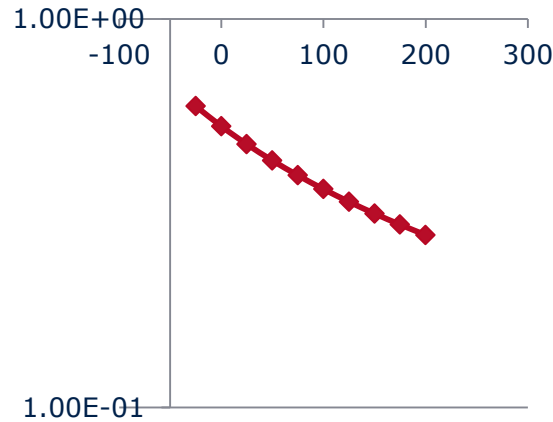
$$IS(T) = \underbrace{IS(T_0) \left[\frac{T}{T_0} \right]^{XTI/N}}_{IS(T)} \cdot \underbrace{\exp \left[\frac{EG}{N \cdot V_T(T_0)} \left(1 - \frac{T_0}{T} \right) \right]}_{IS-Multiplier}$$

$$I_D(T) = IS(T) \cdot \left[\exp \left(\frac{EG}{N \cdot V_T(T_0)} \right) - 1 \right]$$

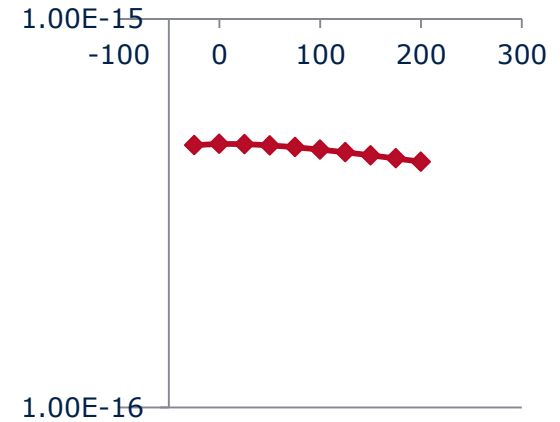
IS(T)



IS-Multiplier



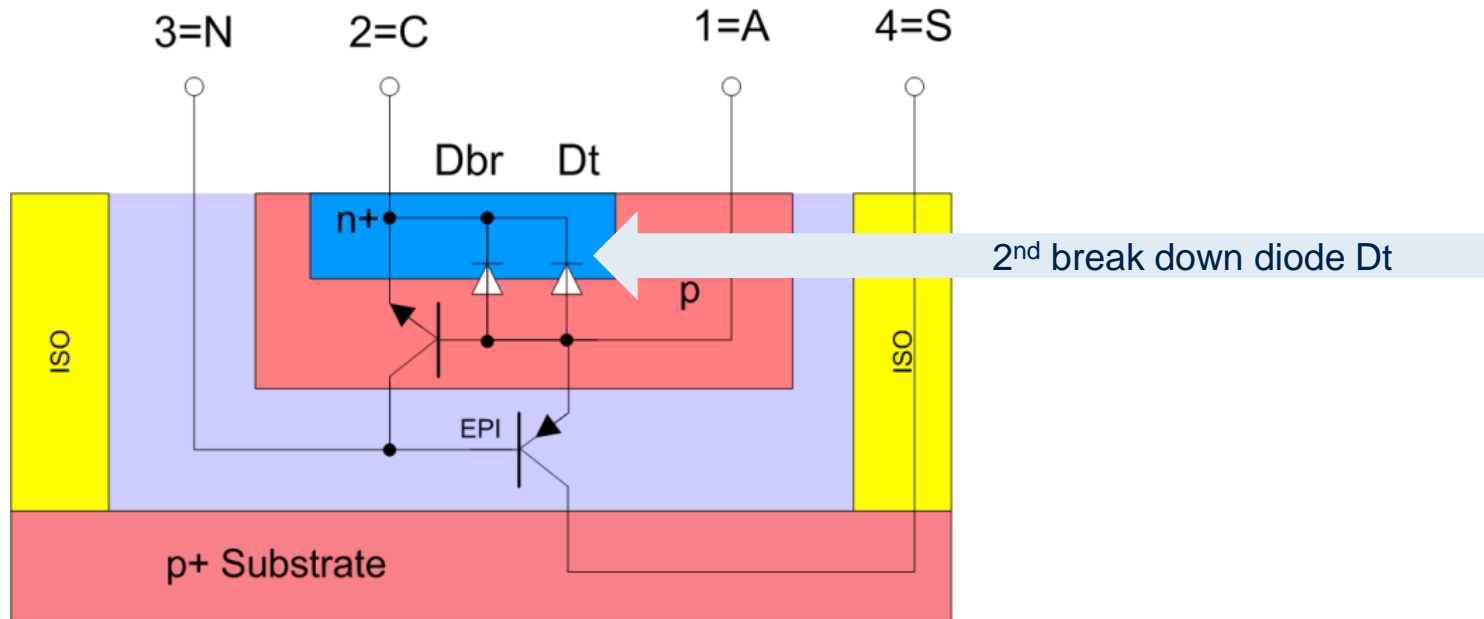
Id(T)



calculated using IS=1a, EG=1.11, XTI=3, **N=40**

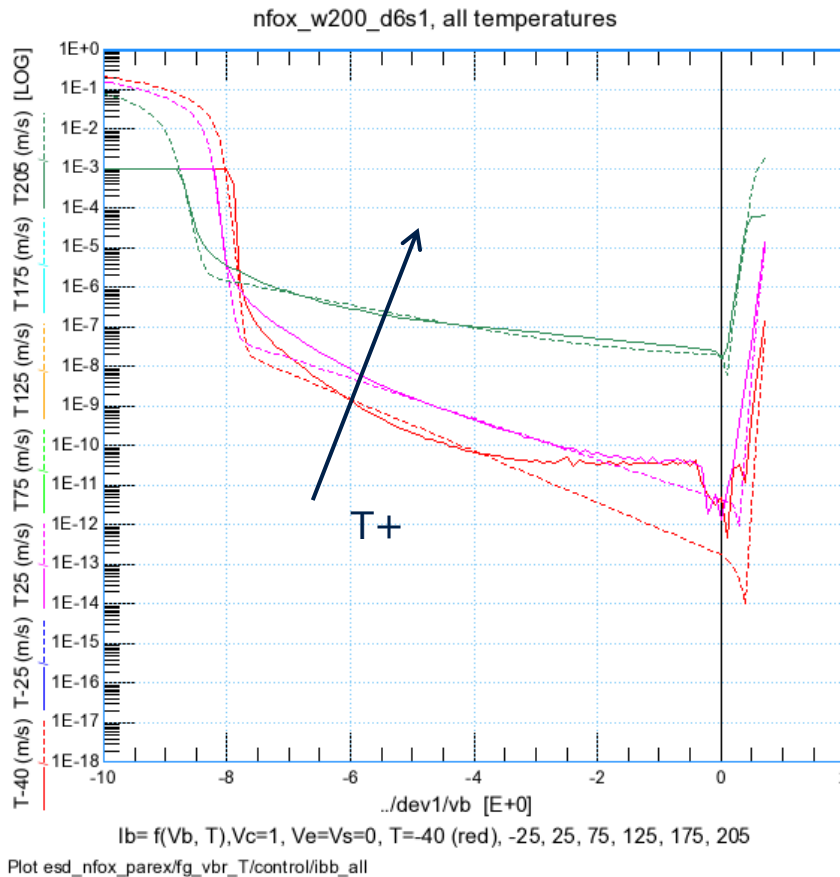
■ Result negative TC of Id for N=40

Tunnel current modeling using 2nd parallel break down diode Dt



- Tunnel current may be better modelled using a 2nd breakdown diode Dt, if some conditions are taken into account

Tunnel current modeling using 2nd parallel break down diode Dt

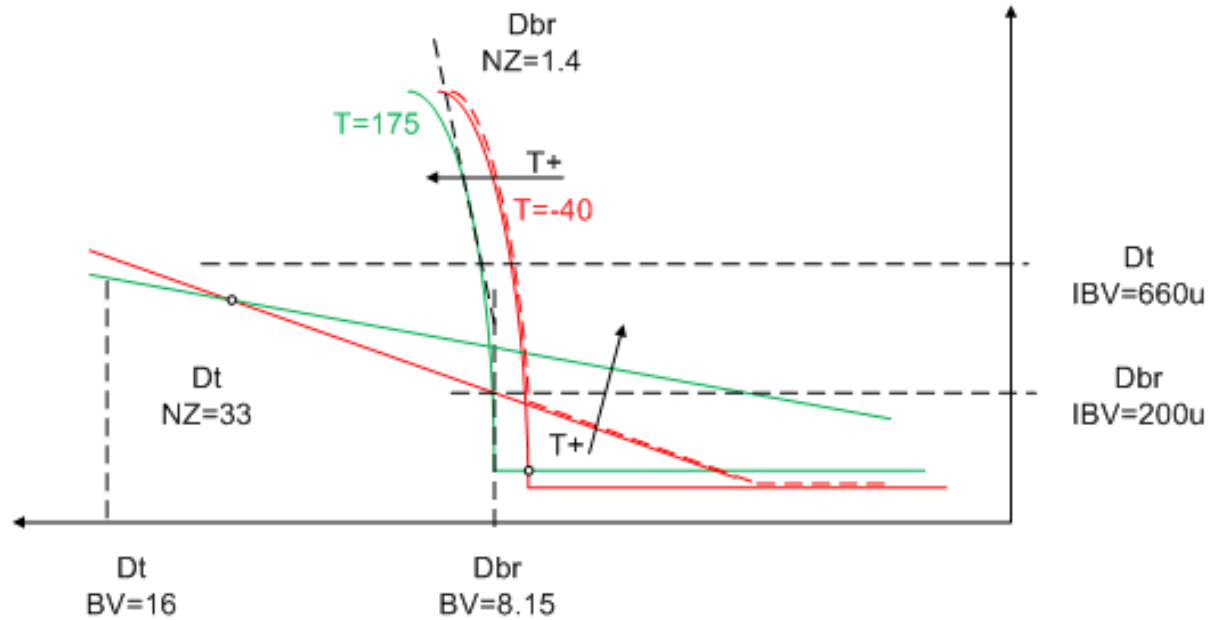


T=-40 T=25 T=205

- 2nd breakdown diode Dt allows to model the right temperature behaviour of the tunnel current

Tunnel current modeling using

How to choose the model parameters?



■ How to choose the model parameters:

- Use $BV_{Dt} \approx 2BV_{Dbr}$ and $IV_{BDT} > IBV_{Dbr}$
- Use $NZ_{DT} \gg 1$

■ Note: Cross section point of the temperature dependent curves of Dt must be shifted to the left



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